

Notice of References Cited	Application/Control No. 10/584,133		Applicant(s)/Patent Under Reexamination TAKEI ET AL.	
	Examiner DAVID NHU		Art Unit 2895	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7190354 B2	03-2007	Tanaka et al	345/17.3
*	C	US-7427361 B2	09-2008	Small et al	252/79.1
*	D	US-7094514 B2	08-2006	Serizawa et al	430/126
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NON-PATENT DOCUMENTS

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